Certificate of analysis

Indium foil, 2.0mm (0.08in) thick, Puratronic, 99.998% (metals basis)

Stock Number: 11382 Lot Number: 15451

Batch Analysis

All concentrations are quoted in parts per million by weight, and the analysis technique employed was d.c. arc emission spectroscopy, unless otherwise denoted below. Unless otherwise stated, the specification (total metallic impurities) relates to impurities as detected.

Elements sought and limits of detection

Below is a list of limits of detection of impurity elements appropriate to the matrix, analytical standards and methods of analysis used.

Ag	<1	Al	<1	As	50	В	<1	Ва	1	Вi	<1
Ca	<1	Cd	<1	Co	2	Cr	<1	Cs	20	Cu	<1
Ga	<1	Ge	<1	Нg	30	K	<1	Li	<1	Mg	<1
Mn	<1	Mo	<1	Na	<1	Nb	50	Ni	<1	P	100
Pb	1	Rb	5	Re	5	Sb	3	Si	<1	Sn	<1
Sr	<1	Te	100	Τi	2	\mathtt{Tl}	<1	V	<1	W	10
Zn	20	Zr	30								

Elements detected

Al <1 Ca <1 Cd 3 Fe <1 Mg <1 Ag <1

Certified by:

Quality Control

Paul Cornally

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